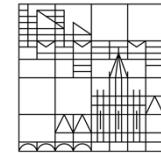


Physikalisches Kolloquium

Universität
Konstanz



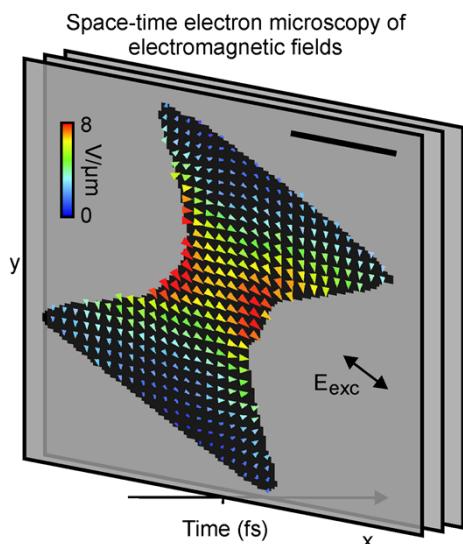
Di 31.01.17
15:15 Uhr
14:45 Uhr, Kaffee/Tee
R 513



Dr. Peter Baum
MPI und LMU München

Understanding Structure and Function by seeing Atoms and Electrons in Motion

All processes in materials, nanostructures and devices are on a fundamental level defined by electronic and atomic motion from initial to final conformations. Our unique approach for a direct, real-space visualization is pump-probe electron diffraction and microscopy [1] with optical-cycle-controlled single-electron wavepackets [2-4]. We achieve simultaneously sub-atomic and sub-light-cycle resolution [4], which allows resolving almost any light-matter interaction or transport phenomenon on fundamental length and time scales. We report on graphite, graphene, carbon nanotubes, strongly correlated materials [5], organic molecular switches, metamaterials [6] and attosecond dynamics in silicon [7]. We conclude with an outlook on how atomic-scale imaging in space and time can help understanding fundamental and complex materials of almost arbitrary complexity and size.



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